

Preparing Authority: Vincent Pugh	G118 - Guidance for Defining the Scope of Accreditation for Calibration Laboratories	Publication Date: 05/16/23
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I. Introduction and Scope

The scope of accreditation of a calibration laboratory is the official and detailed statement of the activities for which the laboratory is accredited. The formulation and assessment of the scope of accreditation represents the core of the accreditation process. The role of the Accreditation Body is to ensure (to an adequate degree of confidence) that the laboratory has the competence to offer the service defined in the scope¹.

Scopes of accreditation serve two purposes:

- a) To define the specific areas of a laboratory's activities which are covered by the laboratory's accreditation (it is recognized that other activities may be undertaken by a laboratory for which it has not sought public recognition of its competence);
- b) To provide the user of an accredited laboratory with a clear description of the specific calibrations covered by the accreditation;

The purpose of this document is to address sources of variability to the extent possible so that all calibration scopes have the same general appearance and level of detail and to outline the requirements for scopes of accreditation.

II. Flexibility and Responsiveness

Assessors and staff need to consider the level of detail included in each scope of accreditation to ensure that there is a practical balance between the amount of information needed by the users of our accredited laboratories and flexibility on the part of accredited laboratories to offer their services within appropriate scopes of their recognized competence.

Too much detail in scopes results in unnecessary demands for constant changes in scopes of accreditation, resulting in processing delays on our end and unwarranted restriction of competent services to laboratory users. Too little detail can result in a laboratory offering accredited calibration service in an area in which it has not been assessed.

In determining the appropriate balance between detail of scopes and flexibility, consideration should be given to the ability of individual labs to update or modify generic methods or to implement new methods (to take account of technological progress or to satisfy changing needs of clients), provided that such changes do not involve significant deviation from the scope and are made only after proper notification to the accreditation body.

Above all, the fundamental considerations relating to the format and information content of scopes have to do with the objectives of having a scope in the first place: the needs of the accredited laboratory and its users which bear on the necessity for consistency following established precedent, avoiding unnecessary complexity and ambiguity, and striving for simplicity, clarity, and uniformity of expression.

III. Contents of Calibration Scopes of Accreditation

1. A2LA scopes include a reference to the general discipline(s) of calibration covered in the scope (e.g., Dimensional, Electrical, Mechanical, etc.);
2. In the parameter column (Parameter/Equipment), the type of equipment or material to be calibrated or measured must be identified. Based on customer request, the Scope may list the specific type of instrument or material (e.g. micrometers, multimeter, etc.), or the type of instrument or material based on the parameter

¹ [ILAC – G18:04/2010 Guideline for the Formulation of Scopes of Accreditation for Laboratories](#)

listed. When the parameter is used to define the instrument(s) or material(s), a foot note must be added (refer to section VIII for example).

3. If a laboratory claims a CMC across a range of values, this value is applicable across the entire range.

For example:

Inappropriate

Parameter/Equipment	Range	CMC ² (±)	Comments
Mass	(1 to 10) kg	70 µg	Class S1 weights

Appropriate

Parameter/Equipment	Range	CMC ² (±)	Comments
Mass	(1 to 10) g (10 to 100) g (0.1 to 1) kg (1 to 10) kg	0.15 mg 0.20 mg 70 mg 0.22 g	Mechanical comparison to Class S1 weights

Or

Parameter/Equipment	Range	CMC ² (±)	Comments
Mass	(1 to 10) kg	0.22 g	Class S1 weights

Per [ILAC-P14:09/2020](#), particular care should be taken when the measurand covers a range of values. This is generally achieved through employing one or more of the following methods for expression of the uncertainty:

- A single value, which is valid throughout the measurement range
- A range. In this case a calibration laboratory should have proper assumption for the interpolation to find the uncertainty at intermediate values
- An explicit function of the measurand or a parameter
- A matrix where the values of the uncertainty depend on the values of the measurand and additional parameters
- A graphical form, providing there is sufficient resolution on each axis to obtain at least two significant figures for the uncertainty

As zero is not technically a valid value for the expression of uncertainty, relative expressions (“%” or “parts in 10⁶”) are not appropriate when the range includes a value of zero or values very close to zero. If a relative expression is used in these instances, it must be used with an absolute term to establish a minimum (floor) uncertainty value (e.g. 1 µV + 0.1 % of reading) to ensure the uncertainty claimed on the scope of accreditation is not zero and is appropriate for the stated range.

A mechanical (or electrical) “zero” of a device under test (DUT) represents a value whereby the DUT is mechanically (or electronically) nulled at a value that is intended to offset systematic, mechanical (or electronic) influences that exist at that specified point (e.g. a micrometer may be “zeroed” through adjustment of the spindle to a minimum value, a caliper may be set to a reading of “zero” when the outside diameter jaws are fully closed, a multimeter may be electronically zeroed with a shorted input, etc.). A mechanical (for electrical) zero condition must be clearly and unambiguously stated as such and, the measurement uncertainty of said “zero” must be metrologically traceable and must have an uncertainty value greater than zero and include considerations of the DUT contributions.

4. The numerical value of the expanded uncertainty is given to, at most, two significant figures. For the process of rounding, the usual rules for rounding of numbers shall be used, subject to the guidance on rounding provided i.e., in Section 7 of the GUM².
5. “Generate” is only used for electrical and microwave/RF disciplines in scopes of accreditation. See section V for more information.
6. Both the International System of units (SI) and US Industry accepted-unit symbols are allowed on scopes, however, unit symbols that are defined in a test method (for example - ASTM) are written exactly as specified in the test method and individual variations are not permitted.
7. When a laboratory lists a specification, or standard method on the scope of accreditation, if the entirety of the specification or standard method cannot be adhered to when performing the calibration, the limitation of the specification or standard method is included on the scope of accreditation.

IV. Recommended Descriptors

A2LA’s classification scheme for various measurement types and parameters is found in [F204 – Scope of Accreditation Selection List: Calibration Laboratories](#).

Any calibration or verification for which A2LA offers accreditation can be placed into one of eleven broad disciplines as follows:

Acoustical quantities such as microphones, sound level, artificial mastoids, and noise dosimeters;

Chemical quantities such as pH meters, conductivity meters, and so on;

Dimensional quantities including length measurements such as laser wavelength, length gages, line scales and distances, length measuring instruments, diameter, form error, roughness, thread quantities, coordinate measuring machines, machine tools and work pieces, and angle measurements such as angle gages, index tables and clinometers;

Electrical quantities including DC/Low Frequency (< 13 MHz) quantities such as voltage, current, voltage ratio, AC/DC transfer (voltage and current), power and energy, resistance, capacitance, inductance, dissipation factor, high voltage quantities, and high voltage impulse quantities as well as RF/Microwave (> 13 MHz) quantities such as impedance (reflection coefficient), power, attenuation, noise, and electric/magnetic field quantities.

Fluid Quantities such as gas and liquid flow rate, volume of flowing gases and liquids, velocity of gases, mass and volume and density of gases and liquids, and viscosity;

Ionizing radiation and radioactivity quantities including radiometric quantities, dosimetric quantities, radioprotection quantities, and activity of radioactive sources;

Magnetic Quantities such as magnetic flux density and magnetic material properties;

Mechanical quantities such as force, mass, weighing instruments, pressure and vacuum quantities, torque, acceleration and vibration, and hardness;

² Evaluation of measurement data – Guide to the expression of uncertainty in measurement JCGM 100:2008 (GUM 1995 with minor corrections).

Optical Quantities such as quantities of optical radiation, photometric quantities, and optical system properties;

Thermodynamic quantities including resistance thermometry, thermocouples, liquid-in-glass thermometers, radiation thermometers, and humidity.

Time and Frequency quantities including time interval, frequency, rise time, and phase angle;

Any question concerning how a measurement not listed above should be classified can be answered simply by identifying the measurand or unit of measure. For example, calibration of electrical temperature indicators/controllers is sometimes placed under the “thermodynamic” section, but since the measurand is, for example, voltage, the proper classification is under “electrical”.

V. Using “generate”, “measuring equipment” and “measure” on Scopes of Accreditation

Scopes of accreditation, particularly in the electrical field, currently use the word “generate” to describe a laboratory’s ability to generate a quantity with a certain level of uncertainty. For example, “DC Volts – Generate” has been taken to mean that a laboratory can generate one or several multiples and/or submultiples of a volt and that its representation of this quantity is accurate to within the claimed level of uncertainty. Thus, laboratories with this capability can calibrate devices used to measure DC Volts.

Although this usage is most prevalent in electrical scopes of accreditation, the same idea is not extended to other disciplines where the inadequacy of this concept for describing a laboratory’s calibration capabilities would not be clear. As such, the use of the “generate” term is only currently used for the electrical and microwave/RF disciplines in scopes of accreditation. Other considerations will be made on a case-by case basis upon written request from the laboratory.

For areas other than the electrical field, the phrase “measuring equipment” is used to describe the laboratory’s ability to generate a quantity with a certain level of uncertainty. In all fields, the use of the word “measure” is used to describe the laboratory’s ability to measure a quantity with a certain level of uncertainty. The three terms “generate”, “measuring equipment” and “measure” are used to define the capability of the laboratory for a measurement parameter and thus clarify what types of instruments they can calibrate.

VI. Reporting the Grade of a Gage Block

When reporting the grade of a Gage Block on a scope of accreditation, the laboratory will also identify the standard measurement method and the publication year of the noted method.

VII. External Guidance

The following external documents can be used for further guidance for the specific disciplines listed:

[G110 – Guidance on Uncertainty Budget for Electrical Parameters](#)

[G111 – Guidance on Pitch Diameter and Simple Pitch Diameter](#)

[G112 – Guidance on 5700A – 5720A – 3458A Artifact Calibrations](#)

[G126 – Guidance on Uncertainty Budgets for Force Measuring Devices](#)

[G127 – Guidance for Reporting Uncertainty for Thunder Scientific Humidity Generators](#)

[G128 – Guidance for DC/AC Power Scope Presentation](#)

[G129 – Measurement Uncertainty Budget Template](#)

[G132 – Technical Guidance from the Measurement Advisory Committee \(MAC\)](#)

VIII. Use of International System of Units (SI) and Other Systems of Units

This section provides information on issues relating to punctuation and layout of unit and quantity symbols on scopes of accreditation.

International System of Units

NIST Special Publications 330, *The International System of Units (SI)*, and 811, *Guide for the Use of the International System of Units (SI)* as well as ASTM SI10 *American National Standard for Use of the International System of Units (SI): The Modern Metric System*, are the primary guidance documents for the use of the SI system of units on A2LA scopes of accreditation. A2LA follows the principles of these documents as closely as possible, however, it is recognized that some obsolete system of units (e.g. inch-pound) is so deeply embedded in American society that it is impossible to present scopes of accreditation solely in terms of the SI. Therefore, it is necessary to strike a balance between best practice (exclusive use of the SI) and practical necessities.

The units of the SI and those units recognized for use with the SI are used to express the values of quantities. Equivalent values in other units are given in parentheses following values in acceptable units when deemed necessary for the intended audience.

Abbreviations such as sec (for either s or second), cc (for either cm³ or cubic centimeter), or mps (for either m/s or meter per second), are avoided and only standard unit symbols, SI prefix symbols, unit names, and SI prefixes are used.

The SI unit of torque is specified as the newton meter (N·m) rather than Joule (J). If indicating Torque for calibration activities using the imperial system, it shall be presented in terms of force x length ensuring the formatting aligns with the SI.

The combinations of letters “ppm,” “ppb,” and “ppt,” and the terms part per million, part per billion, and part per trillion, and the like, as well as the use of scientific notation with quantity symbols, should not be used to express the values of quantities.

NOTE: An Example of how “ppm” is equivalent to “μX/X” are noted below, where (10⁻⁶) = μ (micro) and (10⁻¹²) = p (pico):

3 ppm on 1 V range = 3 μV/V:

$$\begin{aligned} 3 \text{ ppm} &= 3 \cdot (10^{-6}) \text{ of 1 V per 1 V range} \\ &= 3 \cdot (10^{-6}) \cdot [1 \text{ V}/1 \text{ V}] \\ &= 3 \cdot \mu \cdot [\text{V}/\text{V}] \\ &= 3 \mu\text{V}/\text{V} \end{aligned}$$

For frequency parameters, a fixed point is listed in the range column and the CMC is listed as either X parts in 10^{xx} of the value of the range or with the quantity symbol for frequency.

Note: An Example of how a CMC of 2 parts in 10¹¹ at 10 MHz equals 0.2 mHz:

2 parts in 10¹¹ of 10 MHz means 0.2 mHz:

$$\begin{aligned} 2 \text{ parts in } 10^{11} &= 2 \cdot (10^{-11}) \cdot [10 \cdot 10^6 \text{ Hz}] \\ &= 2 \cdot (10^{-11}) \cdot [10^7 \text{ Hz}] \\ &= 2 \cdot 10^{-4} \text{ Hz} \\ &= 0.20 \text{ mHz} \end{aligned}$$

Other Systems of Units

Because there are no official symbols or abbreviations in the English customary systems, A2LA applies the SI rules to the use of English symbols.

Unit symbols that are defined in, for example, ASTM test methods are written exactly as specified in the test method with no individual variations. The principles explained above applies to the use of any unit symbol defined in a test method.

IX. Model Scope of Accreditation

The following pages present a model scope of accreditation for a fictitious calibration laboratory. This model scope illustrates the principles of this document and also shows instances where it was necessary to compromise those principles (e.g., use of the inch-pound system of units) based on established practice in a particular industry.

SCOPE OF ACCREDITATION TO ISO/IEC 17025:2017 & ANSI/NCSL Z540-1-1994

SOME CALIBRATION LAB, INC.
Street Address
City, State Zip
Contact Name Phone: 123 456 7890

CALIBRATION

Valid To: MM DD, YYYY

Certificate Number: 0000.01

In recognition of the successful completion of the A2LA evaluation process, accreditation is granted to this laboratory to perform the following calibrations^{1, 7}:

I.--Dimensional

Parameter/Equipment	Range	CMC ^{2, 3, 4} ($\pm$)	Comments
Gage Blocks	Up to 4.0 in	$(2.0 + L) \mu\text{in}$	Master gage blocks
Outside Micrometers	Up to 1.0 in	$0.48R \mu\text{in}$	Gage blocks

II.--Electrical – DC/Low Frequency

Parameter/Equipment	Range	CMC ^{2, 5, 6} ($\pm$)	Comments
DC Voltage – Measure	(1 to 10) V (10 to 300) V	$16 \mu\text{V/V} + 1.0 \mu\text{V}$ $12 \times 10^{-6} \text{ V}$	HP 3458A
DC Voltage – Generate	(1 to 330) mV (1 to 3.3) V	$25 \mu\text{V/V} + 1.0 \mu\text{V}$ $15 \mu\text{V/V} + 2.0 \mu\text{V}$	Fluke 5520A

III.--Thermodynamics

Parameter/Equipment	Range	CMC ^{2, 6} (±)	Comments
Temperature – Measure Equipment	Approx. -196 °C -80 °C -40 °C	0.025 °C (25 mK) 0.040 °C (40 mK) 0.040 °C (40 mK)	Liquid nitrogen

¹ This laboratory offers commercial and field calibration service.

² Calibration and Measurement Capability Uncertainty (CMC) is the smallest uncertainty of measurement that a laboratory can achieve within its scope of accreditation when performing more or less routine calibrations of nearly ideal measurement standards of nearly ideal measuring equipment. CMC's represent expanded uncertainties expressed at approximately the 95 % level of confidence, usually using a coverage factor of $k = 2$. The actual measurement uncertainty of a specific calibration performed by the laboratory may be greater than the CMC due to the behavior of the customer's device and to influences from the circumstances of the specific calibration.

³ Field calibration service is available for this calibration. Please note the actual measurement uncertainties achievable on a customer's site can normally be expected to be larger than the CMC found on the A2LA Scope. Allowance must be made for aspects such as the environment at the place of calibration and for other possible adverse effects such as those caused by transportation of the calibration equipment. The usual allowance for the uncertainty introduced by the item being calibrated, (e.g. resolution) must also be considered and this, on its own, could result in the actual measurement uncertainty achievable on a customer's site being larger than the CMC.

⁴ In the statement of CMC, L is the numerical value of the nominal length of the gage block in inches, R is the numerical value of the resolution of the micrometer in micro inches.

⁵ The stated measured values are determined using the indicated instrument (see Comments). This capability is suitable for the calibration of the devices intended to measure or generate the measured value in the ranges indicated. CMC are expressed as either a specific value that covers the full range or as a fraction/percentage of the reading.

⁶ The type of instrument or material being calibrated is defined by the parameter. This indicates the laboratory is capable of calibrating instruments that measure or generate the values in the ranges indicated for the listed measurement parameter.

⁷ This scope meets A2LA's [P112 Flexible Scope Policy](#).

***Note:** The CMCs on this example scope are not intended to be typical or representative or otherwise desirable uncertainties, they are shown merely for illustrative purposes.

X. APPENDICES

APPENDIX A: Hardness

Direct verification is calibration of each of the significant features of the testing machine and includes the force and depth indication. The verification of the dimensional features of the indenter is by direct measurement and by performance testing / indirect verification (for Rockwell only).

Although repeatability and error are distinct measurands with generally different uncertainties, scopes of accreditation reference only the uncertainty of a single hardness measurement taken in the course of these verifications.

Indirect Verification of Rockwell Hardness

The scope of accreditation for the indirect verification of Rockwell hardness testers includes the following information:

- The scales the lab is able to verify
- The CMC for a single hardness measurement
- Reference to the indirect verification of Rockwell hardness testers by the method of ASTM E18
- For each scale, three ranges are indicated (low, middle, and high) with corresponding CMCs

When indirectly verifying a portable tester, the ASTM document E110 is used. Care is taken to ensure the portable tester is not a comparative tester that electronically converts or uses charts to convert test values to hardness numbers. A tester can only meet ASTM E110 if it has the same test parameters as those specified in ASTM E10 and ASTM E18.

Sample 1 - Scope of Accreditation for Indirect Verification of Rockwell Hardness Testers

Parameter/Equipment	Range	CMC ($\pm$)	Comments
Indirect Verification of Rockwell Hardness Testers	HRC: Low Medium High	0.31 HRC 0.32 HRC 0.37 HRC	Indirect verification per ASTM E18
Indirection Verification of Superficial Hardness Testers	HRW: Low Medium High	0.31 HRW 0.32 HRW 0.37 HRW	Indirect verification per ASTM E18

Notes:

- 1) There is no need to list the actual hardness values of the reference blocks (generic reference to the range is sufficient) since this creates an unnecessary need to update the scope of accreditation if new blocks are obtained. Only if the lab wishes to update the CMCs should it be necessary to revise the scope when new blocks are obtained.

Direct Verification for Rockwell Hardness

The scope of accreditation for the direct verification of Rockwell hardness testers contains the following information:

Verification of the test force:

- The range of forces the lab can verify
- The associated CMC's
- A reference to ASTM E74

Note: At this point in time, the error component of force cannot be converted to hardness values. All hardness uncertainties are calculated using indirect verification from uncertainty annex shown in ASTM E18.

Verification (direct) of the indenter (optional):

- The feature(s) measured;
- Its associated CMC.
- Where only a performance test for the indenter is made, the scope will simply note, "Indenter is verified only through the performance test."
- Carbide balls
- Hardness of the ball (using, ASTM E384 or ISO 6507 Vickers)
- Geometry of the ball

- Density of the ball

Note: All or some of the above may be determined by other laboratories if they are accredited.

Verification of the depth-measuring device.

- Range of verification of the depth-measuring device
- The CMC
- The method of verification

Note: In many cases, depth verification cannot be performed in the field because of tester incompatibilities. It may be necessary to list those types of testers which can be verified directly in the field.

If a laboratory is accredited for a partial direct verification, this fact is noted on the scope so that potential customers will know that an accredited, full direct verification is not available.

Sample 2 - Scope of Accreditation for Direct Verification of a Rockwell Hardness Tester

Parameter/Equipment	Range	CMC ($\pm$)	Comments
Direct Verification of Rockwell Hardness Testers –			Direct verification method per ASTM E18
Verification of the test force	150 kgf	1.0 kgf	Verification of the test force is by load cell per the method of ASTM E74
Diamond indenter	See ASTM E18, ISO 6507 Tip Radius Angle Straightness of the generatrix line of the cone	1.0 μm 0.10 $^\circ$ 1.0 μm	The dimensional characteristics of the diamond indenter
Carbide ball indenter	Hardness Radius Density	12 HV 1.0 μm 0.10 gcm^{-3}	
Verification of the depth-measuring device	(0 to 4) mm	0.30 μm	

Notes:

- 1) Ranges need to be specified for the parameters of a direct verification. The nominal value of every feature is specified in ASTM E18.
- 2) CMCs are required for the verification of the force indication and verification of the depth-measuring device. If the dimensional characteristics of the diamond indenter are verified, then uncertainties need to be specified as well as measurement method, but no ranges.

Standardization of test blocks: Several features of standardized test blocks are specified in ASTM E18. The following features are considered to be trivially easy to verify and therefore do not warrant accreditation: block thickness, block surface area³, demagnetization.

Sample 3 - Scope of Accreditation for Calibration of Standardized Rockwell and Rockwell Superficial Test Blocks

Parameter/Equipment	Range	CMC ($\pm$)	Comments
Calibration of Standardized Rockwell Hardness and Rockwell Superficial Hardness Test Blocks: Mean hardness value (HRC scale)	HRC: Low Medium High	0.37 HRC 0.32 HRC 0.30 HRC	ASTM E18

Notes:

- 1) Verification of the dimensional characteristics of test blocks is not generally found on scopes of accreditation. In those cases, the scope should note that flatness, parallelism, and surface roughness are not verified and that the calibration is a limited calibration.
- 2) If the block calibration laboratory is not in full compliance with the block geometry specifications of ASTM E18, that calibration will not be listed on the scope.

Indirect Verification of Vickers Hardness

The scope of accreditation for the indirect verification of Vickers hardness testers includes the following information:

- Levels of hardness for which the lab has standardized test blocks
- A reference to the indirect verification by the method of ASTM E92
- The CMC given in terms of HV

Sample 4 - Scope of Accreditation for Indirect Verification of Vickers Hardness Testers

Parameter/Equipment	Range	CMC ($\pm$)	Comments
Indirect Verification of Vickers Hardness Testers	(100 to 240) HV (>240 to 600) HV >600 HV	5.0 HV 8.0 HV 12 HV	Indirect verification per ASTM E92

³ However, certificates for blocks that exceed the 4 in² surface area limitation of ASTM E18 cannot bear the A2LA accredited symbol.

Direct Verification of Vickers Hardness

The scope of accreditation for the direct verification of Vickers hardness testers includes the following information:

1) Verification of the test force:

- The range of forces the lab can verify
- The associated CMC
- A reference to ASTM E74

2) Verification of the indenter:

Unlike Rockwell diamond indenters, ASTM E92 does not specify a performance test for Vickers indenters. Therefore, each of the dimensions specified in ASTM E92 must be checked either by direct measurement or by projection. These features are:

- a) Angle between opposite faces of the pyramid
- b) Inclination of the four faces to the axis of the pyramid
- c) Junction of indenter faces for indenters used in routine testing
- d) Junction of indenter faces for indenters used for calibrating standardized test blocks
- e) Angles of the quadrilateral formed by the intersection of the four faces of the indenter with a plane perpendicular to the axis of the indenter

All laboratories wishing to be accredited for the direct verification of Vickers hardness testers are accredited for items a – c and e. Laboratories wishing to be accredited for the direct verification of Vickers hardness testers used for the calibration of standardized test blocks are accredited for at least items a, b, d, e or obtain from an accredited source a directly verified indenter.

3) Verification of the measuring microscope:

- CMC
- An indication of the method of verification

Laboratories that cannot perform each of these verifications are not normally be accredited for the direct verification of Vickers hardness testers. If a laboratory is accredited for a partial direct verification, this fact is noted on the scope so that potential customers will know that an accredited, full direct verification is not available.

Sample 5 - Scope of Accreditation for Direct Verification of a Vickers Hardness Tester

Parameter/Equipment	Range	CMC ($\pm$)	Comments
Direct Verification of Vickers Hardness Testers –			Direct verification method per ASTM E92
Verification of the test force	5 kgf	1.0 kgf	Verification of the test force is by load cell per the method of ASTM E92
Verification of the dimensional characteristics of the indenter:			Verification of these dimensional features is by optical projection.
Angle between opposite faces of the pyramid		7.0'	

Inclination of the faces to the axis of the pyramid		7.0'	
Junction of indenter faces for indenters used in routine testing		0.25 mm	
Junction of indenter faces for indenters used for calibrating standardized test blocks		0.12 mm	
Angles of the quadrilateral formed by the intersection of the four faces of the indenter with a plane perpendicular to the axis of the indenter	(0 to 200) μm	3.0'	
Verification of the device for measuring indentation diagonals		0.28 μm	

Notes:

- 1) Ranges need to be specified for the parameters of a direct verification except for force (since not every lab will necessarily be capable of verifying the entire force range). The nominal value of every other feature is specified in ASTM E92.

Standardization of test blocks: Several dimensional features of standardized test blocks are specified in ASTM E92 but the only non-trivial block geometry such as surface roughness, flatness and thickness are demonstrated.

Sample 6 - Scope of Accreditation for Calibration of Standardized Vickers Test Blocks

Parameter/Equipment	Range	CMC ($\pm$)	Comments
Calibration of Standardized Vickers Test Blocks	(100 to 240) HV (>240 to 600) HV >600 HV	4.0 HV 6.0 HV 10 HV	ASTM E92

Indirect Verification of Brinell Hardness

The scope of accreditation for the indirect verification of Brinell hardness testers includes the following information:

- Specification of each of the conditions the laboratory is accredited to verify
- A reference to the indirect verification by ASTM E10

Sample 7 - Scope of Accreditation for Indirect Verification of Brinell Hardness Testers

Parameter/Equipment	Range	CMC ($\pm$)	Comments
Indirect Verification of Brinell Hardness Testers at Test Condition(s) – HBW 10/3000/15	(200 to 399) HBW (400 to 600) HBW	4.0 HBW 8.0 HBW	Indirect verification method per ASTM E10

Notes:

- 1) The notation HBW 10/3000/15 gives the conditions of the verification: in this example, “10” is the diameter of the indenter in millimeters, “3000” is the test force in kilogram-force and “15” is the duration of force application in seconds.

Direct Verification of Brinell Hardness

The scope of accreditation for Brinell Hardness includes the following information:

- 1) Verification of the test force.

- The test forces the lab can verify (Standard test forces for Brinell hardness testing are 3000 kgf, 1500 kgf, and 500 kgf)
- The associated CMC's
- A reference to ASTM E10

- 2) Verification of the indenter:

Unlike Rockwell diamond indenters, ASTM E10 does not specify a performance test for Brinell indenters. Therefore, the mean diameter of a Brinell ball indenter must be determined per ASTM E10 section 15.1.2 and the ball must be selected at random from a lot meeting the hardness requirements specified in section 5.2 of ASTM E10. If the laboratory manufactures indenter balls and they wish to be accredited for indenter lot hardness certifications, then this will be a separate line item on the scope.

- 3) Verification of the measuring device:

- The range of verification of the measuring device
- The CMC
- The method of verification

Laboratories that cannot perform each of these verifications are not normally be accredited for the direct verification of Brinell hardness testers. If a laboratory is accredited for a partial direct verification, this fact is noted on the scope so that potential customers will know that an accredited, full direct verification is not available.

Sample 8 - Scope of Accreditation for Direct Verification of a Brinell Hardness Tester

Parameter/Equipment	Range	CMC ($\pm$)	Comments
Direct Verification of Brinell Hardness Testers – Verification of the device for measuring indentation diameters	(1 to 7) mm	0.028 mm	Direct verification per ASTM E10.

Standardization of test blocks: Several features of standardized test blocks are specified in ASTM E10.

Sample 9 - Scope of Accreditation for Calibration of Standardized Brinell Test Blocks

Parameter/Equipment	Range	CMC ($\pm$)	Comments
Calibration of Standardized Brinell Hardness Test Blocks – Mean hardness value	≤ 225 HBW > 225 HBW	5.0 HBW 10 HBW	ASTM E10

Notes:

- 1) Verification of the dimensional characteristics of test blocks is not generally found on scopes of accreditation.

Indirect Verification of Microindentation Hardness (Knoop and Vickers)

The scope of accreditation for the indirect verification of microindentation hardness testers (Knoop and Vickers) includes the following information:

- Levels of hardness for which the lab has standardized test blocks
- A reference to the indirect verification by the method of ASTM E92
- The CMC given in terms of HV or HK

Sample 10 - Scope of Accreditation for Indirect Verification of Microindentation Hardness Testers

Parameter/Equipment	Range	CMC ($\pm$)	Comments
Indirect Verification of Microindentation Hardness Testers (Knoop and Vickers)	(100 to 250) HK (250 to 650) HK >650 HK (100 to 240) HV	3.0 HK 8.0 HK 12 HK 7.0 HV	Indirect verification method per ASTM E92

Direct Verification of Microindentation Hardness (Knoop and Vickers)

The scope of accreditation for the direct verification of microindentation hardness testers (Knoop and Vickers) includes the following information:

1) Verification of the indenter:

The features to be verified on the Vickers and Knoop indenters are:

- a) Vickers: face angles, offset, inclination of the faces to the axis of the indenter
- b) Knoop: indenter constant, included longitudinal edge angle, included transverse edge angle, offset, inclination of the faces to the axis of the indenter

2) Force verification:

- The range of forces the lab can verify
- Associated CMC's
- A reference to ASTM E92

3) Measuring microscope verification:

- The CMC's
- An indication of the method of verification

Laboratories that cannot perform each of these verifications are not normally be accredited for the direct verification of microindentation hardness testers. If a laboratory is accredited for a partial direct verification, this fact is be noted on the scope so that potential customers will know that an accredited, full direct verification is not available.

Sample 11 - Scope of Accreditation for Direct Verification of a Vickers Hardness Tester

Parameter/Equipment	Range	CMC($\pm$)	Comments
Direct Verification of Vickers and Knoop Hardness Testers –			Direct verification method per ASTM E92
Verification of the test force	1000 gf	3.0 gf	Verification of the test force is by load cell per the method of ASTM E92
Verification of the dimensional	----		Verification of these dimensional features

characteristics of the indenter:			is by optical projection
Vickers		7.0'	
Face angles		0.13 mm	
Offset		7.0'	
Inclination of the faces to the axis of the indenter		7.0'	
Verification of the dimensional characteristics of the indenter:			
Knoop			
Included longitudinal edge angle, A		0.10'	
Included transverse edge angle, B		0.10'	
Indenter constant, cp		0.00018	
Offset		0.25 μ m	
Inclination of the faces to the axis of the indenter		7.0'	
Verification of the device for measuring indentation diagonals		0.12 % of reading	

Notes:

- 1) No ranges need to be specified for the parameters of a direct verification except for force (since not every lab will necessarily be capable of verifying the entire force range). The nominal value of every other feature is specified in ASTM E92.

Standardization of Test Blocks

The scope of accreditation for standardization of test blocks includes the following:

- Uniformity of hardness and mean of the hardness values found during the standardization
- A range
- The CMC given in terms of HK

The following features are considered to be trivially easy to verify and therefore do not warrant accreditation: block thickness and demagnetization.

**Sample 12 - Scope of Accreditation for Calibration of Standardized Hardness Test Blocks for
Microindentation Hardness Test**

Parameter/Equipment	Range	CMC ($\pm$)	Comments
Calibration of Standardized Microindentation Hardness Test Blocks	(100 to 250) HK (250 to 650) HK >650 HK	4.0 HK 9.0 HK 12 HK	ASTM E384

APPENDIX B: Dimensional Testing

Some of the organizations accredited under the Mechanical field of testing for dimensional testing are actually performing calibration measurements as part (or all) of the measurements that they make. This situation is especially prevalent in dimensional measurement laboratories using coordinate measuring machine (CMMs) to perform their measurements.

When the dimensional measurement laboratory is measuring what is commonly referred to as "hard tooling" or fixed gauges, there are times when that measured tool is going to be used by the laboratory's customer as the reference standard to measure their own parts. In those cases, the dimensional measurement laboratory is serving as a link in the traceability chain and is treated by A2LA and our assessors as a calibration laboratory. In these situations, the requirements found in [R205 – Specific Requirements: Calibration Laboratory Accreditation Program](#) are applied in order to accredit the dimensional measurement organization for this service.

It is understood that some of the dimensional measurements are performed as a small part of the mechanical scope or calibration scope of accreditation and that much of the work is taking measurements of automotive parts, for example, to ensure an appropriate fit on the automobile; this is considered dimensional testing.

If a situation arises where a mechanical testing organization desires to include dimensional testing capability for which the unit under test does serve as link in the traceability chain on their scope of accreditation or a calibration organization desires to include dimensional testing capability for which the unit under test not serve as link in the traceability chain, A2LA will accredit the organization without requiring them to hold a separate Scope of Accreditation.

1. For all dimensional testing parameters for which the unit under test does serve as link in the traceability chain:
 - The CAB meets the requirements of A2LA [R205 - Specific Requirements: Calibration Laboratory Accreditation Program](#).
 - A footnote identifying that the organization meets A2LA [R205 - Specific Requirements: Calibration Laboratory Accreditation Program](#) for the types of dimensional tests listed and is considered equivalent to that of a calibration is included in the scope of accreditation. Furthermore, this is also identified on the test report.

Example Mechanical Testing Scope or Calibration Scope presentation when the dimensional test does serve as a link in the traceability chain:

I. Dimensional Testing/Calibration¹

Parameter/Equipment	Range	CMC ^{2, 4} (±)	Comments
One Dimensional ³ – Length Radius	Up to 6 in Up to 6 in	0.32 millinch 0.28 millinch	Optical comparator
Length Standards (1D) ³	(0.01 to 25) in	(75 + 2.0L) µin	CMM

¹ This laboratory offers commercial dimensional testing/calibration service.

² Calibration and Measurement Capability Uncertainty (CMC) is the smallest uncertainty of measurement that a laboratory can achieve within its scope of accreditation when performing more or less routine calibrations of nearly ideal measurement standards or nearly ideal measuring equipment. CMC's represent expanded uncertainties expressed at approximately the 95 % level of confidence, usually using a coverage factor of $k = 2$. The actual measurement uncertainty of a specific calibration performed by the laboratory may be greater than the CMC due to the behavior of the customer's device and to influences from the circumstances of the specific calibration.

³ This laboratory meets [R205 – Specific Requirements: Calibration Laboratory Accreditation Program](#) for the types of dimensional tests listed above and is considered equivalent to that of a calibration.

⁴ In the statement of CMC, L is the numerical value of the nominal length of the device expressed in inches.

2. For all dimensional testing parameters for which the unit under test **does not** serve as link in the traceability chain the following applies for the presentation of the scope:
- The parameter, range, and Technique and/or Test Method (Standard) are identified on the scope (3 column scope)
 - Units for Angle measurements degrees, minutes and seconds, use the following corresponding symbols: °, ', ''
 - Normally the range cannot begin with zero. Instead "Up to" or a number greater than zero is used.
 - For Parameters, each word is capitalized
 - For Techniques, only first word is capitalized
 - For the process of rounding, the usual rules for rounding of numbers shall be used, subject to the guidance on rounding provided i.e.in Section 7 of the GUM⁴
 - The following footnote is included in the scope of accreditation "This test is not equivalent to that of a calibration." Furthermore, this is also identified in the test report
 - Use of the term "length" requires a qualifier

⁴ Evaluation of measurement data – Guide to the expression of uncertainty in measurement JCGM 100:2008 (GUM 1995 with minor corrections).

Example Mechanical Testing or Calibration Scope Presentation when dimensional testing does not serve as a link in the traceability chain:

I. Dimensional Testing¹

Parameter	Range	Technique / Method
Angle ²	1° to 360°	Optical comparator
Radius ²	(0.005 to 3) in	Optical comparator

¹ This laboratory offers commercial dimensional testing service only.

² This test is not equivalent to that of a calibration.

3. For dimensional testing parameters for which the unit under test does serve as link in the traceability chain for some parameters but does not serve as a link in the traceability chain for other parameters:
- For those parameters that *do* serve as a link in the traceability chain, the requirements of APPENDIX B.1 applies
 - For the dimensional test that *does not* serve as link in the traceability chain, the requirements of APPENDIX B.2 applies

Example Scope Presentation when dimensional testing *does* and *does not* serve as a link in the traceability chain:

I. Dimensional Testing/Calibration¹

Parameter/Equipment	Range	CMC ² (±)	Comments
Length Standards (1D) ³	Up to 25 in	(75 + 2.0L) μin	CMM
Gridplates (2D) ³	(6 x 8) in	(60 + 5.0L) μin	Vision CMM
Fixture Gages (3D) ³	(20 x 25 x 15) in	(200 + 5.0L) μin	CMM

II. Dimensional Testing⁴

Parameter	Range	Technique/ Method
Angle ⁵	1° to 360°	Optical comparator

Workpiece Measurement ⁵ –		
1D 2D 3D	Up to 25 in (20 x 25) in (20 x 25 x 15) in	CMM
1D 2D	Up to 8 in (6 x 8) in	Vision CMM

¹ This laboratory offers commercial dimensional testing/calibration service.

² Calibration and Measurement Capability Uncertainty (CMC) is the smallest uncertainty of measurement that a laboratory can achieve within its scope of accreditation when performing more or less routine calibrations of nearly ideal measurement standards or nearly ideal measuring equipment. CMC's represent expanded uncertainties expressed at approximately the 95 % level of confidence, usually using a coverage factor of $k = 2$. The actual measurement uncertainty of a specific calibration performed by the laboratory may be greater than the CMC due to the behavior of the customer's device and to influences from the circumstances of the specific calibration.

³ This laboratory meets [R205 – Specific Requirements: Calibration Laboratory Accreditation Program](#) for the types of dimensional tests listed above and is considered equivalent to that of a calibration.

Note: This footnote must be identified with a parameter.

⁴ This laboratory offers commercial dimensional testing service only.

⁵ This test is not equivalent to that of a calibration.

Note: This footnote must be identified with a parameter.

⁶ In the statement of CMC, L is the numerical value of the nominal length of the device measured in inches.

APPENDIX C: Durometer

Typically, a user of an accredited calibration provider will request that their durometer be calibrated to the ASTM D2240 standard. This standard is prescriptive as to what parameters must be measured during a calibration of a durometer and what must be reported on the instrument calibration report. The required parameters identified in this document are based upon the ASTM D2240 standard.

Where a durometer is included on the scope of accreditation the following is identified and included in the scope:

- The types of durometers that the facility is accredited to calibrate, that is type, A, B, C, D, DO, E, M, O, OO, OOO, OOO-S, and R. The accredited facility would then only be able to offer an accredited calibration for the durometer scales listed on their scope of accreditation.
- The following measurement capabilities in regard to the extension and shape of the indenter: Diameter, Radius, Angle, & Extension
- A parameter for the display of the indenter
- A parameter for the force measurement of the durometer spring

Example Scope of Accreditation – Durometer

I. Mechanical

Parameter/Equipment	Range	CMC ($\pm$)	Comments
Durometer Calibration – (List applicable durometer types, A, B, C, D, DO, E, M, O, OO, OOO, OOO-S, and R)			ASTM D2240
Indenter Extension and Shape –			
Diameter			
Radius			
Angle			
Extension			
Indenter Display			
Spring Calibration – Force			

For more information on Durometer see Appendix C of A2LA R205: Specific Requirements: Calibration Laboratory Accreditation Program.

APPENDIX D: Adjustable Threaded Ring Gages

Calibration of Adjustable Threaded Ring Gages: For the process of checking a threaded ring gage with a master plug gage and then mechanically adjusting the ring gage the scope is represented as follows. An appropriate footnote also accompanies the parameter.

Parameter/Equipment	Range	CMC ($\pm$)	Comments
Adjustable Thread Rings ⁴	Up to 12 in	XX (Set Plug Tolerance)	Set using master plug gages. ASME/ANSI B1.2-1983 and ASME/ANSI B1.3-2007

⁴Adjustable thread rings are set to applicable specifications using calibrated master set plug gages.

APPENDIX E: S-Parameters

For RF/Microwave S-Parameters where the CMC is expressed as a range, the laboratory shall indicate the basis for determining the values in the CMC range through the use of an appropriate footnote, such as the following:

‘The CMC uncertainty for the intermediate value of the measurement can be found by {insert type} interpolation’

APPENDIX F: Oscilloscopes

Calibration of Oscilloscopes: For the process of calibrating an Oscilloscope, or using an Oscilloscope to measure Rise Time, the scope is represented as follows:

Parameter/Equipment	Range	CMC ($\pm$)	Comments
Oscilloscopes – Amplitude – DC Signal 50 Ω Load 1 M Ω Load Amplitude – Square Wave 50 Ω Load	1 mV _{p-p} to 6.6 V _{p-p} 1 mV _{p-p} to 130 V _{p-p} 1 mV _{p-p} to 6.6 V _{p-p} ; 10 Hz to 100 kHz	1.9 mV/V + 31 μ V 0.39 mV/V + 31 μ V 2.0 mV/V + 31 μ V	Fluke 5520A/SC1100

Parameter/Range	Frequency	CMC ($\pm$)	Comments
Oscilloscopes – (cont) Amplitude – Square Wave 1 M Ω Load Bandwidth	1 mV _{p-p} to 130 V _{p-p} ; 10 Hz to 100 kHz 5 mV to 5.5 V 50 kHz to 100 MHz (100 to 300) MHz (300 to 600) MHz (600 to 1100) MHz	0.78 mV/V + 31 μ V 3.0 % + 78 μ V 3.4 % + 78 μ V 4.3 % + 78 μ V 4.9 % + 78 μ V	Fluke 5520A/SC1100

Time Marker	5 s to 50 ms 1 ns to 20 ms	7.8 ms/s 39 μ s/s	
Pulse Characterization – Rise Time – Generate	1 kHz to 2 MHz; (200 to 300) ps (2 to 10) MHz; (200 to 350) ps	55 ps 65 ps	Fluke 55XX/SC1100 Tektronix 80E01
Rise Time – Measure	1 kHz to 10 MHz; (21 to 350) ps	3 % + 25 ps	
Pulse Characterization – Rise Time – Generate	10 Hz to 20 MHz; (460 to 540) ps 10 Hz to 2 MHz; (125 to 175) ps 10 Hz to 1 MHz; (59 to 81) ps 10 Hz to 1 MHz; (21 to 29) ps	20 ps 24 ps 30 ps 35 ps	Fluke 9510/30 Fluke 9530 Fluke 9560 Fluke 9550
Rise Time – Measure	10 Hz to 10 MHz; 350 ps to 1 ms	3 % + 24 ps	Tektronix 1 GHz oscilloscope

APPENDIX G: AC/DC Power (Energy)

A/C DC Power (Energy) can be generated by discreet components, specialized test sets or multifunction calibrators. Power can be measured by instantaneous reading devices (watt meters, watt transducers), or cumulative devices that measure power over time (watthour meters.)

In each case Scopes of Accreditation for AC and DC Power must contain the following elements:

- Range of measurement expressed in Watts, Volt Amperes or VARs (Volt Amperes Reactive)
- The Power Factor and/or Phase Angle for AC Power
- The CMC expressed in Watts, Volt Amperes, VARs or percent.
- The Frequency (AC Power)

Example Scopes of Accreditation are as follows:

Parameter/Equipment	Range	CMC ² (±)	Comments
DC Power – Generate	109 µW to 1 mW (1 to 11) mW (11 to 108) mW 108 mW to 11 W 11 W to 5 kW (5 to 12) kW	0.03 % 0.03 % 0.06 % 0.03 % 0.09 % 0.07 %	Multifunction calibrator

Parameter/Equipment	Range	CMC ^{2, 4, 7} (±)	Comments
AC Power – Generate (45 to 65) Hz PF=1	109 µW to 1 mW (1 to 4) mW (4 to 1) mW (11 to 40) mW (40 to 396) mW 396 mW to 11 W (11 to 264) W 264 W to 3 kW (3 to 11) kW	0.03 % 0.19 % 0.19 % + 0.06 nW 0.12 % + 0.06 nW 0.12 % + 0.58 nW 0.19 % + 5.76 nW 0.12 % 0.16 % 0.12 %	Multifunction calibrator

Parameter/Equipment	Range	CMC ^{2, 3} (±)	Comments
AC Energy – Generate Watt-Hours (-60° to 60°) Phase Angle (50 to 60) Hz	16.7 mWh to 33.3 kWh	11 µWh/VAh	Watt-hour standard
Parameter/Equipment	Range	CMC ^{2, 3} (±)	Comments
AC Energy – Generate VAR-Hours (120 to 600) V @ 60 Hz (120 to 480) V @ 50 Hz (0.2 to 200) A (-90° to 60°) Phase Angle	16.7 mVARh to 33.3 kVARh	15 µVARh/VAh	Watt-hour standard
AC Energy – Measuring Equipment			

(45 to 65) Hz 12 mV to 650 V	1.9 mW/VAR to 35 kW/kVAR	0.84 %	Watt-hour standard
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APPENDIX H: Optical Comparators

The scope of accreditation for the calibration of Optical Comparators should contain the following information:

- Length:
 - Etched on glass artifact (glass reticle)
 - Ball block
 - Other applicable reference standard
- Angle:
 - Etched on glass artifact (glass reticle)
 - Angle block set
 - Other applicable reference standard
- Magnification:
 - Etched on glass artifact (glass reticle)
 - Go No-Go artifact
 - Mag checker
 - Other applicable reference standard

Example Scope of Accreditation is as follows:

Parameter/Equipment	Range	CMC ² (±)	Comments
Optical Comparators –			
Length – X, Y	(1 to 12) in	85 µin + 0.6R	Glass master
Angular	0° to 90°	1°	Angle block set
Magnification	10x to 250x	0.014 in	Glass master

* These 3 sub-parameters would constitute a full calibration. If 2 or less are posted on the CABs scope of accreditation, the CAB would only be able to provide a limited calibration certificate.

XI. Definitions

For the purpose of these Requirements, the relevant terms and definitions given in ISO/IEC 17000 and the VIM apply. General definitions related to quality are given in Q9000, whereas ISO/IEC 17000 gives definitions specifically related to standardization, certification and laboratory accreditation. Where different definitions are given in Q9000, the definitions in ISO/IEC 17000 and VIM are preferred.

Best Existing Device⁵: is defined as a device to be calibrated that is commercially or otherwise available for customers, even if it has a special performance (stability) or has a long history of calibration.

⁵ Adapted from [ILAC P14:09/2020 ILAC Policy for Measurement Uncertainty in Calibration](#)

Calibration and Measurement Capability Uncertainty (CMC)⁶: a CMC is a calibration and measurement capability available to customers under normal conditions:

- a) As described in the laboratory's scope of accreditation granted by a signatory to the ILAC Arrangement; or
- b) as published in the BIPM⁷ key comparison database (KCDB) of the CIPM MRA⁸.

Conformity Assessment Body (CAB): body that performs conformity assessment activities and that can be the object of accreditation

Note: Whenever the term "Conformity Assessment Body" or "CAB" is used in the text, it applies to both the applicant and accredited CABs, unless otherwise specified.

Measurement Uncertainty (VIM3 clause 2.26): Non-negative parameter characterizing the dispersion of the quantity values being attributed to a measurand, based on the information used.

Metrological Traceability⁹: property of a measurement result whereby the result can be related to a reference through a documented unbroken chain of calibrations, each contributing to the measurement uncertainty.

XII. References

[R105 - Requirements When Making Reference to A2LA Accredited Status](#)

[P102 - A2LA Policy on Metrological Traceability](#)

[R101 - General Requirements: Accreditation of ISO/IEC 17025 Laboratories](#)

[R103 - General Requirements: Proficiency Testing for ISO-IEC 17025 Laboratories](#)

ANSI/ISO/ASQ Q9000:2015, *Quality management systems – Fundamentals and vocabulary*.

ANSI/NCSL Z540-1-1994, Part I, *Calibration Laboratories and Measuring and Test Equipment- General Requirements*.

BIPM JCGM 200:2012, *International vocabulary of metrology - Basic and general concepts and associated (VIM) 3rd edition (2008 version with minor corrections)*.

CIPM MRA-D-04, *Calibration and Measurement Capabilities in the context of the CIPM MRA* Version 5 March 2017

BIPM JCGM 100:2008, *Evaluation of measurement data – Guide to the expression of uncertainty in measurement (GUM 1995 with minor corrections)*.

[ILAC-P8:03/2019, ILAC Mutual Recognition Arrangement \(Arrangement\): Supplementary Requirements and Guidelines for the Use of Accreditation Symbols and for Claims of Accreditation Status by Accredited Conformity Assessment Bodies](#)

[ILAC P10:07/2020, ILAC Policy on Traceability of Measurement Results](#).

[ILAC P14:09/2020 ILAC Policy for Measurement Uncertainty in Calibration](#)

[ILAC G8:09/2019, Guidelines on Decision Rules and Statements of Conformity](#)

ISO/IEC 17025:2017, *General requirements for the competence of testing and calibration laboratories*.

ISO/IEC 17000:2020 *Conformity assessment – Vocabulary and general principles*.

⁶ Per the CIPM MRA-D-04, *Calibration and Measurement Capabilities in the context of the CIPM MRA*, Version 5 March 2017.

⁷ For the BIPM KCDB see <https://www.bipm.org/kcdb/>

⁸ For the CIPM MRA see <http://www.bipm.org/en/cipm-mra/>

⁹ Per JCGM 200:2012 *International vocabulary of metrology – Basic and general concepts and associated terms (VIM) 3rd edition*.

ISO/IEC 17043:2010 - Conformity assessment -- General requirements for proficiency testing.

NIST Technical Note 1297, *Guidelines for Evaluating and Expressing the Uncertainty of NIST Measurement Results*, Taylor, Barry N., Kuyatt, Chris E., U.S. Government Printing Office, Washington, D.C., 1993.

UKAS, *The Expression of Uncertainty and Confidence in Measurement* (M3003), 2019.

ANSI/NCSL Z540.3-2006, Sub-clause 5.3, *Requirements for the Calibration of Measuring and Test Equipment*.

DOCUMENT REVISION HISTORY

Date	Description
10/18/21	➤ Updates made related to 2020 revisions of ILAC P10 and ILAC P14. ➤ Added clarification regarding expression of CMC measurement uncertainty across a range that includes zero as a measurement value. ➤ Updated references section.
01/13/23	➤ Editorial updates to format and font for consistency ➤ Addition of force x length units in section VIII ➤ Addition of Appendix H for optical comparators
05/16/23	➤ Updated hyperlinks for the references